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## 10-Bit Serial-Output Temperature Sensors with 5-Channel ADC

### **General Description**

The MAX1098/MAX1099 implement both local and remote temperature sensing with 10-bit resolution, using +5V and +3V supply voltages, respectively. Accuracy is ±1°C from 0°C to +70°C, with no calibration needed. The devices feature an algorithmic switched-capacitor analog-to-digital converter (ADC), on-chip clock, and 3-wire serial interface compatible with SPI™, QSPI™, and MICROWIRE™.

The MAX1098/MAX1099 also perform fully differential voltage measurements with 10-bit resolution and separate track-and-hold (T/N) for positive and negative inputs. Both devices accept versatile input modes consisting of two 3-channel signal pairs, five 1-channel signals relative to a floating common, or V<sub>DD</sub>/4 relative to ground. An external reference may be used for more accurate voltage measurements.

Typical power consumption is only 1.3mW (MAX1099). A shutdown mode and two standby modes provide multiple strategies for prolonging battery life in portable applications that require limited sampling throughput.

The MAX1098/MAX1099 are available in 16-pin SSOP packages.

### Applications

**Pin Configuration** 

Temperature/Voltage Supervision of Workstations and Communications Equipment Hand-Held Instruments

Medical Equipment

Industrial Process Control



### Typical Operating Circuit appears at end of data sheet.

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### M/IXI/M

### Features

- Local and Remote Temperature Sensing
- 12-Bit Resolution for Temperature and 10-Bit Resolution for Voltage Inputs
- ±1°C Accuracy from -40°C to +85°C
- Fully Differential Inputs
- Single-Supply Operation +4.75V to +5.25V (MAX1098) +2.7V to +3.6V (MAX1099)
- 3-Wire SPI/QSPI/MICROWIRE-Compatible Interface
- Internal Precision Voltage Reference 2.50V (MAX1098) 1.20V (MAX1099)
- Space-Saving 16-Pin SSOP Package

#### **Ordering Information** TEMP. SENSE PIN-TEMP. ACCURACY PART RANGE PACKAGE (°C) MAX1098AEAE\* -40°C to +85°C ±0.75 16 SSOP MAX1098BEAE\* -40°C to +85°C 16 SSOP ±1.0 MAX1098CEAE -40°C to +85°C 16 SSOP ±4.0 MAX1099AEAE\* -40°C to +85°C 16 SSOP ±0.75 MAX1099BEAE\* -40°C to +85°C 16 SSOP ±1.0 MAX1099CEAE -40°C to +85°C 16 SSOP ±4.0

\*Future product—contact factory for availability.

### **Temperature Error**



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### **ABSOLUTE MAXIMUM RATINGS**

V <sub>DD</sub> to GND SHO to GND	
Analog Inputs to GND	
(AIN0–AIN5, REF)	0.3V to (V <sub>DD</sub> +0.3V)
Digital Inputs to GND (DIN, SCLK, CS)	0.3V to (V <sub>DD</sub> +0.3V)
Digital Outputs to GND (DOUT, SSTRB)	0.3V to (V <sub>DD</sub> +0.3V)
Digital Output Sink Current	25mÅ
Maximum Current into Any Pin	

Continuous Power Dissipation ( $T_A = +70^{\circ}C$ )	
16-Pin SSOP (derate 8.00mW/°C above +70°C)667mW	
Dperating Temperature Range MAX109 EAE40°C to +85°C	
Junction Temperature+150°C Storage Temperature Range65°C to +150°C	
_ead Temperature (soldering, 10s)+300°C	
_eau remperature (soluening, 105)+300 C	

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

## ELECTRICAL CHARACTERISTICS

 $(V_{DD} = +4.75V \text{ to } +5.25V \text{ (MAX1098)}, V_{DD} = +2.7V \text{ to } +3.6V \text{ (MAX1099)}, \text{ external reference, } V_{REF} = +2.5V \text{ (MAX1098)}, V_{REF} = +1.2V \text{ (MAX1099)}, f_{SCLK} = 2.5MHz, T_A = T_{MIN} \text{ to } T_{MAX}, \text{ unless otherwise noted. Typical values are at } T_A = +25^{\circ}C.)$ 

PARAMETER	SYMBOL	CONDITIONS	MIN	ТҮР	МАХ	UNITS
DC ACCURACY (Note 1)						
Resolution	RES		10			Bits
Relative Accuracy (Note 2)	INL				±1	LSB
Differential Nonlinearity	DNL				±1	LSB
Offset Error		Inputs AIN0–AIN5			±1	LSB
Offset Temperature Coefficient				±10		μV/°C
Gain Error		Inputs AIN0–AIN5, offset nulled			±1	LSB
V <sub>DD</sub> /4 Absolute Error					±1	LSB
Gain Temperature Coefficient				±2		ppm/°C
Channel-to-Channel Offset Matching				±0.25		LSB
CONVERSION RATE						
		Voltage measurement			1.1	
Conversion Time (Note 3)	<b>t</b> CONV	Temperature measurement			2.2	ms
Track/Hold Acquisition Time	tacq			16		μs
Aperture Delay	t <sub>APR</sub>			30		ns
Internal Clock Frequency	fCLK		57.6	62.3	65.5	kHz
ANALOG INPUTS (AIN0-AIN5)						
Input Voltage Range (Note 4)		Measurement with respect to IN-, Figure 1	-2V <sub>REF</sub>		+2V <sub>REF</sub>	V
Common-Mode Range			0		V <sub>DD</sub>	V
Input Current (Note 5)				0.1	5	μΑ
Input Capacitance				16		pF

### **ELECTRICAL CHARACTERISTICS (continued)**

 $(V_{DD} = +4.75V \text{ to } +5.25V \text{ (MAX1098)}, V_{DD} = +2.7V \text{ to } +3.6V \text{ (MAX1099)}, \text{ external reference, } V_{REF} = +2.5V \text{ (MAX1098)}, V_{REF} = +1.2V \text{ (MAX1099)}, \text{ f}_{SCLK} = 2.5MHz, T_A = T_{MIN} \text{ to } T_{MAX}, \text{ unless otherwise noted. Typical values are at } T_A = +25^{\circ}C.)$ 

PARAMETER	SYMBOL	CONDITIONS		MIN	ТҮР	MAX	UNITS	
DIGITAL INPUTS				•			•	
Input Voltage Low	VIL					0.8	V	
Input Voltage High	VIH		V <sub>DD</sub> - 0.8			V		
Input Hysteresis	VHYST				0.2		V	
Input Leakage Current	lin					1	μA	
Input Capacitance					16		рF	
DIGITAL OUTPUTS							V	
Output Low Voltage	Vol	I <sub>SINK</sub> = 5mA				0.6	V	
Output High Voltage	Voh	ISOURCE = 0.5mA		V <sub>DD</sub> - 0.6			V	
Three-State Output Leakage Current	IOUT					±10	μΑ	
Three-State Output Capacitance					15		pF	
POWER REQUIREMENTS				•			•	
		MAX1098		4.75		5.25		
Positive Supply Voltage	V <sub>DD</sub>	MAX1099	2.7		3.6	- V		
		Full-on, voltage measurements,	MAX1098		390			
		internal reference	MAX1099		350			
		Full-on, voltage measurements,	MAX1098		310		1	
		external reference	MAX1099		280			
		Full-on, temperature measurements,	MAX1098		440	500	7	
Positive Supply Current (Note 6)	IDD	internal reference	MAX1099		400	500	μΑ	
(11018-0)		Full-on, temperature measurements,	MAX1098		360			
		external reference	MAX1099		330			
		Standby, SCLK = GND			120		-	
		Standby-plus, SCLK = GND			190			
		Shutdown, SCLK = GND			2	10		
Power-Supply Rejection	PSRR	(Note 7)		50	65		dB	
INTERNAL VOLTAGE REFE	RENCE CH/		-					
Reference Voltage	VREF	$V_{DD} = 5V$	MAX1098	2.494	2.50	2.506	v	
neierenee voltage		V <sub>DD</sub> = 3V	MAX1099	1.197	1.20	1.203	v	
Reference Tempco	TC V <sub>REF</sub>				±20		ppm/°C	
Output Short-Circuit Current						1.25	mA	
Capacitive Bypass at REF				0.1			μF	
		$f_{N} = 10Hz$ to $10kHz$	MAX1098		130		u\/p	
REF Output Noise		f <sub>N</sub> = 10Hz to 10kHz MAX1099			65		μVRMS	
REF Line Regulation			MAX1098		+3.0			
			MAX1099		+0.2		mV/V	
REF Load Regulation		0 to 100µA output current	MAX1098		4	10		
HER LOAD REGULATION		(Note 8)		2	10	μ٧/μΑ		

## **ELECTRICAL CHARACTERISTICS (continued)**

(V<sub>DD</sub> = 4.75V to 5.25V (MAX1098), V<sub>DD</sub> = 2.7V to 3.6V (MAX1099), external reference, V<sub>REF</sub> = +2.5V (MAX1098), V<sub>REF</sub> = +1.2V (MAX1099), f<sub>SCLK</sub> = 2.5MHz, T<sub>A</sub> = T<sub>MIN</sub> to T<sub>MAX</sub>, unless otherwise noted. Typical values are at T<sub>A</sub> = +25°C.)

PARAMETER	SYMBOL	CONDITIO	NS	MIN	TYP	MAX	UNITS	
EXTERNAL VOLTAGE REFERE	NCE CHARA	CTERISTICS					•	
Reference Veltage Range	Vara	MAX1098		0.8		2.5	V	
Reference Voltage Range	VREF	MAX1099		0.8		1.2	v	
		Converting			10		- MΩ	
REF Input Resistance		Shutdown			25		10122	
REF Input Capacitance					24		pF	
INTERNAL TEMPERATURE ME	ASUREMEN	T CHARACTERISTICS						
Resolution					0.13		°C	
			MAX109_A			±0.75		
		$T_A = +85^{\circ}C, P_D = 1mW$	MAX109_B			±1		
			MAX109_C			±1		
			MAX109_A			±0.75		
Output Error (Notes 1, 9)		$T_A = 0^{\circ}C$ to $+70^{\circ}C$	MAX109_B			±1	°C	
			MAX109_C			±2		
		T 4000 - 000	MAX109_A			±0.75		
		$T_A = -40^{\circ}C$ to 0°C, $T_A = +70^{\circ}C$ to +85°C	MAX109_B			±1		
		TA = +70 0 to +00 0	MAX109_C			±4		
Power-Supply Rejection Ratio	PSRR	(Note 7)			0.2		°C/V	
Noise					0.18		°C <sub>RMS</sub>	
EXTERNAL TEMPERATURE M	EASUREMEN	IT CHARACTERISTICS						
Output Error		2N3904 (Note 10)			±2	±4	°C	
Remote Diode Excitation (1X)					10		μΑ	
Remote Diode Excitation (10X)					100		μΑ	

### TIMING CHARACTERISTICS

 $(V_{DD} = +4.75V \text{ to } +5.25V \text{ (MAX1098)}, V_{DD} = +2.7V \text{ to } +3.6V \text{ (MAX1099)}, \text{ external reference, } V_{REF} = +2.5V \text{ (MAX1098)}, V_{REF} = +1.2V \text{ (MAX1099)}, f_{SCLK} = 2.5MHz, T_A = T_{MIN} \text{ to } T_{MAX}, \text{ unless otherwise noted. Typical values are at } T_A = +25^{\circ}C.)$  (Figures 4, 6)

PARAMETER	SYMBOL	CONDITIONS	MIN	ТҮР	MAX	UNITS
SCLK Frequency	<b>f</b> SCLK				2.5	MHz
SCLK Pulse Width Low	tCL		200			ns
SCLK Pulse Width High	tСН		200			ns
CS Low to SCLK High	tcss		100			ns
SCLK High to $\overline{CS}$ Setup	tCSH		100			ns
CS Pulse Width	tcs		100			ns
SCLK High to CS Low Setup	tcso		50			ns
SCLK High to CS High Setup	tCS1		100			ns
DIN Setup to SCLK High Time	t <sub>DS</sub>		100			ns
DIN Hold Time	tDH		0			ns
SCLK Fall to Output Data Valid	tDO	$R_L = 100k\Omega$ , $C_L = 50pF$			150	ns
CS Fall to Output Enable	t <sub>DV</sub>	$R_L = 100k\Omega$ , $C_L = 50pF$			150	ns
CS Rise to Output Disable	t <sub>TR</sub>	$R_L = 100k\Omega$ , $C_L = 50pF$			50	ns
SSTRB Rise to SCLK Rise	<b>t</b> SCLK		0			ns
SCLK Fall to SSTRB Fall	<b>t</b> SSTRB				200	ns

**Note 1:** Tested at  $V_{DD}$  = +5.0V (MAX1098) and  $V_{DD}$  = +3.0V (MAX1099).

Note 2: Relative accuracy is the deviation of the analog value at any code from its theoretical value after the full-scale range has been calibrated.

**Note 3:** Conversion time is defined as the number of clock cycles (64 for voltage measurements, 125 for temperature measurements) multiplied by the internal clock period.

Note 4: Individual analog input voltages cannot extend beyond the power-supply rails.

**Note 5:** Input resistance is typically  $250M\Omega$ ;  $5\mu$ A limit reflects limitations in production testing.

Note 6: Specifications for full-on status assume continuous conversions. Power modes are software selected (Table 3).

Note 7: Measured at VFS(+4.75V) - VFS(+5.25V) for the MAX1098 and at VFS(+2.7V) - VFS(+3.6V) for the MAX1099.

Note 8: External load should not change during conversions for specified accuracy.

Note 9: Excludes noise and self-heating effects. Output error for MAX109\_C guaranteed by design.

Note 10: External temperature sensing over -40°C to +85°C range, device at +25°C. Guaranteed by design.



## **Typical Operating Characteristics**

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### Typical Operating Characteristics (continued)

M/IXI/M



MAX1098/MAX1099

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### **Typical Operating Characteristics (continued)**

### **Pin Description**

PIN	NAME	FUNCTION
1	AIN1	Analog Input 1. Negative differential input relative to AIN0 or positive differential input relative to AIN5 (Table 4). Connect to the cathode of external diode 1 for remote temperature sensing.
2	SHO	Shield Output. Used to suppress leakage currents at the anodes of remote temperature sensors (see <i>Remote Diode Shielding</i> ). May also be connected to the shields of twisted-pair input cables used for remote temperature measurements. Leave unconnected for other applications.
3	AIN2	Analog Input 2. Positive differential input relative to AIN3 or positive differential input relative to AIN5 (Table 4). Connect to the anode of external diode 2 for remote temperature sensing.
4	AIN3	Analog Input 3. Negative differential input relative to AIN2 or positive differential input relative to AIN5 (Table 4). Connect to the cathode of external diode 2 for remote temperature sensing.
5	AIN4	Analog Input 4. Positive differential input relative to AIN5 (Table 4).
6	GND	Ground. Connect to pin 13.
7	SSTRB	Serial Strobe Output. SSTRB goes low at the beginning of an A/D conversion, and it goes high when the conversion is finished.
8	CS	Active-Low Chip Select. Data will not be clocked into DIN unless $\overline{CS}$ is low. When $\overline{CS}$ is high, DOUT is at high impedance.
9	DOUT	Serial Data Output. DOUT transitions on the falling edge of SCLK.
10	DIN	Serial Data Input. DIN latches data on the rising edge of SCLK.
11	SCLK	Serial Clock Input. Clocks data in and out of the serial interface.
12	V <sub>DD</sub>	Positive Supply Voltage. Bypass with a 0.1µF capacitor to GND (pin 13).
13	GND	Ground (star ground)
14	REF	Reference-Buffer Output/ADC Reference Input. Reference voltage for A/D conversion. Bypass to GND (pin 13) with a $0.1\mu$ F capacitor. Select reference mode by writing to configuration byte (Table 1).
15	AIN5	Analog Input 5. Negative differential input relative to AIN0-AIN4 (Table 4).
16	AINO	Analog Input 0. Positive differential input relative to AIN1 or positive differential input relative to AIN5 (Table 4). Connect to the anode of external diode 1 for remote temperature sensing.



Figure 1. MAX1098/MAX1099 Functional Diagram

### **Detailed Description**

The MAX1098/MAX1099 are low-power, serial-output, multichannel ADCs with temperature-sensing capability for thermostatic, process-control, and monitoring applications. An algorithmic switched-capacitor converter with T/H circuitry for both positive and negative inputs supports fully differential 10-bit conversions from an internal temperature sensor, two external temperature sensors, or voltage sources in a variety of channel configurations. Microprocessor ( $\mu P$ ) control is made easy through a flexible 3-wire serial interface.

Figure 1 shows a simplified functional diagram of the MAX1098/MAX1099 internal architecture. In temperature-sensing mode, the multiplexer (mux) steers bias currents through internal or external diodes while the ADC computes their temperature in relation to changes in forward voltage. Channels not used for temperature measurement can be configured to measure other system voltages.



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Figure 2. Converter Input Structure

#### **Converter Operation**

Figure 2 shows a simplified model of the converter input structure. Once initiated, a voltage conversion requires 64 f<sub>CLK</sub> periods, where f<sub>CLK</sub> is the internal master clock. Each conversion is preceded by 13 f<sub>CLK</sub> periods of warm-up time, performed in twelve 4 f<sub>CLK</sub> period cycles, and followed by three f<sub>CLK</sub> periods to load the output register. SSTRB falls at the beginning of a conversion and rises at the end of a conversion.

Inputs IN+ and IN- charge capacitors CHOLDP and C<sub>HOLDN</sub>, respectively, during the acquisition interval that occurs during the first f<sub>CLK</sub> period of the first conversion cycle. In the second f<sub>CLK</sub> period, the T/H switches open so that charge is retained on C<sub>HOLDP</sub> and C<sub>HOLDN</sub> as a sample of the differential voltage between IN+ and IN-. This charge is transferred to the ADC during the third and fourth f<sub>CLK</sub> periods.

The reference sampling process begins in the second conversion cycle and continues until the conversion is complete. Sampling occurs during the second and fourth f<sub>CLK</sub> periods to yield an effective doubling of the reference voltage. The reference sampling requirement

is signal dependent and may or may not occur in every subsequent conversion cycle.

Temperature conversion is nothing more than subtracting the results of two sequential voltage conversions. The only difference is that output registers are not loaded at the end of the first conversion. Thus, temperature conversions require  $2 \times 64 - 3 = 125$  f<sub>CLK</sub> periods. Figures 3a and 3b show timing diagrams for voltage and temperature conversions, respectively.

#### Track/Hold

The T/H stage for the MAX1098/MAX1099 is a simple switched-capacitor sampling operation. The time required for the T/H stage to acquire an input signal is a function of how fast its input capacitance is charged. If the signal source impedance is high, the acquisition time lengthens and more time must be allowed between conversions. The acquisition time (tACQ) is the maximum time the device takes to acquire the signal. Calculate this with the following equation:

#### $t_{ACQ} = 7 (R_s + R_{IN}) C_{IN}$

where  $R_S$  is the source impedance of the input signal,  $R_{IN}$  is the T/H input impedance (40k $\Omega$ ), and  $C_{IN}$  is the





Figure 3a. Voltage Conversion Timing Diagram



Figure 3b. Temperature Conversion Timing Diagram

input sampling capacitance of the ADC (4pF). Source impedances below 100 k  $\Omega$  have no significant effect on MAX1098/MAX1099 AC performance.

#### **Analog Input Protection**

Internal protection diodes clamp the analog inputs to V<sub>DD</sub> and GND so channels can swing within GND - 0.3V and V<sub>DD</sub> + 0.3V without damage. However, for accurate conversions, the inputs should not extend beyond the supply rails.

If an off-channel analog input extends beyond the supply rails, limit the input current to 2mA.

### **Serial Digital Interface**

The MAX1098/MAX1099 feature a serial interface that is fully compatible with SPI, QSPI, and MICROWIRE devices. For SPI/QSPI, ensure that the CPU serial interface runs in master mode so it generates the serial clock signal. Select a 2.5MHz clock frequency or less, and set zero values for clock polarity (CPOL) and phase (CPHA) in the  $\mu$ P control registers. Figure 4 shows detailed serial interface timing information. See Tables 1–4 for programming information.



Figure 4. Detailed Serial Interface Timing



Figure 5. Bipolar Transfer Function

#### Input Data Format

Input data (configuration and conversion bytes) are clocked into the MAX1098/MAX1099 at DIN on the rising edge of SCLK when  $\overline{CS}$  is low. The start bit (MSB) of an input data byte is the first logic 1 bit that arrives: After  $\overline{CS}$  falls

### OR

After receipt of a complete configuration byte with no conversion in progress

### OR

After 16 bits have been clocked onto DOUT following a conversion.

#### Output Data Format

Output data from the MAX1098/MAX1099 are clocked onto DOUT on the falling edge of SCLK in the form of two 8-bit words, MSB first (Table 5). For temperature conversions, the output is 12-bit binary (D8–S2) padded with 2 leading extraneous bits and two trailing zeros. For voltage conversions, the output is 10-bit two's-complement binary (D9–D0) with 3 sub-bits and two trailing zeros. Figure 5 shows the bipolar transfer function.

#### Performing a Conversion

On power-up, the MAX1098/MAX1099 default to shutdown mode. Start a conversion by transferring a configuration byte and a conversion byte into DIN with the control formats shown in Tables 1 and 2, respectively. (See *Power Modes* for a related discussion.)

SSTRB goes low on the falling edge of the last bit of the conversion byte, and it returns high when the conversion is complete. For best noise performance, SCLK should remain low while SSTRB is low. Typical conversion times are 2.2ms for temperature measurements and 1.1ms for voltage measurements. The MSB of the 2 output bytes is present at DOUT starting at the rising edge of SSTRB. Successive SCLK falling edges shift the two 8-bit data bytes out from an internal register. Additional (>16) SCLK edges will result in zeros on DOUT.

<u>SSTRB</u> does not go into <u>a high-impedance</u> state when <u>CS</u> goes high. Pulling <u>CS</u> high prevents data from being clocked in or out, but it does not adversely affect a conversion in progress. Figure 6 shows SSTRB timing details.

Subsequent conversions with the same reference mode do not require a configuration byte.



BIT 7 (MSB)	BIT 6	BIT 5	BIT 4	BIT 3	BIT 2	BIT 1	BIT 0 (LSB)					
Start	0	0	0	0	PM1	PM0	REF					
BIT	NAME		DESCRIPTION									
7 (MSB)	Start	First logic 1 aft	er $\overline{\text{CS}}$ goes low. (	See Input Data F	Format.)							
6, 5, 4, 3		Must be 0000	o load a configura	ation byte.								
2, 1	PM1, PM0	These 2 bits se	elect the desired p	oower mode (Tab	ole 3).							
0	REF		nables the interna ernal reference m		gic low disables t	he internal referer	nce and					

### Table 1. Configuration-Byte Format

### Table 2. Conversion-Byte Format

SEL1, SEL0

BIT 7 (MSB)	BIT 6	BIT 5	BIT 4	BIT 4 BIT 3 BIT 2		BIT 1	BIT 0 (LSB)				
Start	0	1 0		SEL3	SEL2	SEL1	SEL0				
BIT	NAME			DESCF	RIPTION						
7 (MSB)	Start	First logic 1 aft	er CS goes low. (	See Input Data F	Format.)						
6, 5, 4		Must be 010 to	Must be 010 to load a conversion byte.								
3 2 1 0	SEL3, SEL2,	Those 4 bits of	leat the input on	ofiguration (Table	4)						

These 4 bits select the input configuration (Table 4).



Figure 6. Detailed SSTRB Timing

3, 2, 1, 0

### **Reference Selection**

Select between internal and external voltage modes through bit REF of the configuration byte. Set REF = 1 for internal reference mode and REF = 0 for external reference mode.

### Internal Reference

The MAX1098 has a 2.50V internal reference, while the MAX1099 has a 1.20V internal reference. Both are factory trimmed for accuracy. When internal reference is selected, REF can be used to drive an external load with 100µA capability. Bypass REF to GND with a 0.1µF minimum capacitance. Wake-up time is C x 2.5 x 10<sup>4</sup>s for the MAX1098 and C x 1.2 x 10<sup>4</sup>s for the MAX1099.

#### External Reference

The MAX1098 can directly accept reference voltages at REF from 0.8V to 2.5V, while the MAX1099 can directly accept reference voltages from 0.8V to 1.2V. Bypass REF to GND with a 0.1 $\mu$ F capacitor. Temperature measurements always use internal reference.

### **Power Modes**

The MAX1098/(MAX1099) typically requires supply currents of 380µA (350µA) or 310µA (280µA) when performing voltage conversions at 100% duty cycle with internal or external references, respectively. The differ-

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ence reflects the power requirement of an internal reference buffer amplifier that can accommodate external loads. Temperature conversions at 100% duty cycle increase supply currents to  $440\mu A$  ( $400\mu A$ ) through additional amplification, buffer, and bias circuitry that is otherwise inactive.

Place the MAX1098/MAX1099 in a low-current powerdown state between conversions to conserve power. Select standby, standby plus, or shutdown through bits PM1 and PM0 of the initialization byte (Table 3).

The MAX1098/MAX1099 assume the shutdown power mode when  $V_{DD}$  is first applied.

#### Standby Mode

Standby mode turns off the MAX1098/MAX1099 ADC, internal clock, and reference buffer amplifier. Special circuitry for temperature conversions is also deactivated. Wake-up time is limited by the reference buffer amplifier and the associated bypass capacitor (see *Internal Reference*). When an external reference is used, wake-up time is 0.1ms.

#### Standby-Plus Mode

Standby-plus mode is similar to the standby mode, but the internal reference output buffer remains active to shorten the wake-up time to 0.1ms for internal reference mode. When using an external reference, standby-plus mode is equivalent to standby mode.

#### Shutdown Mode

Shutdown mode turns off all functions other than startup circuitry, thereby reducing typical supply current to  $2\mu$ A. Data registers are cleared. Use this power mode when interconversion times are no less than 5ms.

#### Monitoring VDD

This mode of operation samples and converts the supply voltage,  $V_{DD}/4$ , which is internally generated. The reference voltage must be larger than  $V_{DD}/8$  for the operation to work properly. From the result of a conversion (CODE), CODE = 64 V\_{DD} / V\_{REF}.

### **Temperature Measurements**

The MAX1098/MAX1099 perform temperature measurements with internal or external diode-connected transistors through a three-step process. First, the diode bias current changes from 31.6 $\mu$ A to 10 $\mu$ A to produce a temperature-dependent bias voltage difference, which is amplified by a factor of 20 and converted to digital format. Second, the bias current changes from 31.6 $\mu$ A to 100 $\mu$ A, and the bias voltage difference is similarly amplified by a factor of 20 and converted to digital format. Third, the intermediate results are subtracted to

### **Table 3. Power-Mode Selection**

See Power Requirements in Electrical Characteristics.

PM1	PM0	MODE
0	0	Shutdown
0	1	Standby plus
1	0	Standby
1	1	Normal operation

achieve a digital output that is proportional to absolute temperature in degrees Kelvin.

The reference voltage used in conjunction with temperature measurements is derived from the internal reference source to ensure that 1LSB corresponds to 1/8 of a degree. To convert to degrees Celsius, subtract 273.15 from the temperature inferred from the ADC output.

Temperature measurements require a conversion time of 2.2ms.

### **Shield Output Buffer**

The MAX1098/MAX1099 provide a shield output buffer voltage at SHO that is approximately 0.6V (one diode drop) above V<sub>DD</sub>/2. When performing temperature measurements with an external diode, use this voltage to suppress error-producing leakage currents (see *Remote Diode Shielding*). Figure 7 shows the SHO output circuit.



Figure 7. SHO Output Circuit

### Applications Information

### **Remote Diode Selection**

Temperature accuracy depends on having a goodquality, diode-connected, small-signal transistor. Accuracy has been experimentally verified for 2N3904 devices. CPUs and other ICs having on-board temperature-sensing diodes can also be monitored if the diode connections are floating.

### **Table 4. Input Selection**

SEL3	SEL2	SEL1	SEL0	POSITIVE INPUT (IN+)	NEGATIVE INPUT (IN-)
0	0	0	0	AINO	AIN5
0	0	0	1	AIN1	AIN5
0	0	1	0	AIN2	AIN5
0	0	1	1	AIN3	AIN5
0	1	0	0	AIN4	AIN5
0	1	0	1		
0	1	1	0	AIN5	AIN5
0	1	1	1	Internal diode anode*	Internal diode cathode
1	0	0	0	AINO	AIN1
1	0	0	1	AIN2	AIN3
1	0	1	0		_
1	0	1	1	V <sub>DD</sub> /4	GND
1	1	0	0	External diode 1 anode* (AIN0)	External diode 1 cathode (AIN1)
1	1	0	1	External diode 2 anode* (AIN2)	External diode 2 cathode (AIN3)
1	1	1	0		
1	1	1	1		

\*Temperature-measurement mode

### Table 5. Output Data Format

								D0			20	01	00	0	~
D9	D9	D8	D/	D6	D5	D4	D3	D2	D1	D0	50	5	- 52	0	0
_	-	-		-	-		-			-		-	-	-	
-															

The transistor must be a small-signal type with a base resistance less than  $100\Omega$ . Tight specifications for forward current gain (+50 to +150, for example) indicate that the manufacturer has good process controls and that the devices have consistent  $V_{be}$  characteristics. (See Table 6 for recommended devices.)

For heatsink mounting, the 500-32BT02-000 thermal sensor from Fenwal Electronics is a good choice. This device consists of a diode-connected transistor, an aluminum plate with screw hole, and twisted-pair cable (Fenwal Inc., Milford MA, 508-478-6000).

### **Twisted-Pair and Shielded Cables**

For remote-sensor distances greater than 8 inches, or in particularly noisy environments, use a twisted-pair cable. A practical length is 6 feet to 12 feet. For longer distances, the best solution is a shielded twisted-pair cable such as that used for audio microphones. For

# Table 6. Remote-Sensor TransistorManufacturers

MANUFACTURER	MODEL NUMBER
Central Semiconductor (USA)	CMPT3904
Fairchild Semiconductor (USA)	MMBT3904
Motorola (USA)	MMBT3904
Rohm Semiconductor (Japan)	SST3904
Siemens (Germany)	SMB3904
Zetex (England)	FMMT3904CT-ND



Figure 8. Remote Diode Shielding for PC Boards

example, the Belden 8451 works well for distances up to 100 feet in a noisy environment. Connect the shield to SH0-0H.

Cable resistances affect remote-sensor accuracy;  $1\Omega$  series resistance introduces +0.45°C error.

### **Remote Diode Shielding**

Temperature measurements will reflect significant error if a portion of the bias current supplied to the diode anode is allowed to flow through parallel paths to ground. If the diode-connected transistor is mounted on a PC board, suppress error-producing "leakage" current by surrounding the collector/base leads with a metal trace that is connected to the SHO shield output (Figure 8).

### Layout, Grounding, and Bypassing

For best performance, use PC boards. Do not use wirewrap boards. Board layout should ensure that digital and analog signal lines are separated from each other. Do not run analog and digital (especially clock) signals parallel to one another or run digital lines underneath the ADC package.

High-frequency noise in the V<sub>DD</sub> power supply may affect ADC performance. Bypass the supply with a 0.1 $\mu$ F capacitor close to pin V<sub>DD</sub>. Minimize capacitor lead lengths for best supply-noise rejection. If the power supply is very noisy, connect a 10 $\Omega$  resistor in series with the supply to provide lowpass filtering.

### Definitions

### **Relative Accuracy**

Relative accuracy is the deviation of the values on an actual transfer function from a straight line. This straight line can be either a best-straight-line fit or a line drawn between the endpoints of the transfer function, once offset and gain errors have been nullified. The static linearity parameters for the MAX1098/MAX1099 are measured using the best-straight-line fit method.

### **Differential Nonlinearity (DNL)**

Differential nonlinearity is the difference between an actual step width and the ideal value of 1LSB. A DNL error specification of less than 1LSB guarantees no missing codes and a monotonic transfer function.

#### **Offset Error**

Offset error is the difference between the ideal and the actual offset points. For an ADC, the offset point is the midstep value when the digital output is zero.

#### **Gain Error**

Gain or full-scale error is the difference between the ideal and actual gain points on the transfer function, after the offset error has been canceled out. For an ADC, the gain point is the midstep value when the digital output is full scale.

### **Aperture Delay**

Aperture delay (t<sub>AD</sub>) is the time defined between the rising edge of the sampling clock and the instant when an actual sample is taken.

### **Chip Information**

TRANSISTOR COUNT: 13,669 PROCESS: BICMOS

## \_Typical Operating Circuit



### **Package Information**



Maxim cannot assume responsibility for use of any circuitry other than circuitry entirely embodied in a Maxim product. No circuit patent licenses are implied. Maxim reserves the right to change the circuitry and specifications without notice at any time.

MAX1098/MAX1099

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